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SEP 13 2005

Practitioner's Docket No. MI22-2379

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Warren M. Farnworth, et al.

Application No.: 10/632,273

Group No.: 2829

Filed: July 31, 2003

Examiner: Russell M. Kobert

Title: Method and Apparatus for Testing Semiconductor Circuitry for Operability and Method of Forming Apparatus for Testing Semiconductor Circuitry for Operability

Commissioner for Patents
Washington, D.C. 20231

CERTIFICATION OF FACSIMILE TRANSMISSION

I hereby certify that the following papers are being facsimile transmitted to the Patent and Trademark Office at (571) 273-8300 on the date shown below:

1. Facsimile Transmittal
2. Examiner Interview Summary of September 7, 2005

September 13, 2005
Date

Julie A. Foster
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Total Pages: 3

Although it is believed that no fees are due, the Commissioner is hereby authorized to charge any fees under 37 C.F.R. 1.16 and 1.17 which may be required by this paper to Deposit Account No. 23-0925.

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No.10/632,273
Filing Date July 31, 2003
Inventor.....Warren M. Farnworth, et al.
Assignee.....Micron Technology, Inc.
Group Art Unit.....2829
Examiner Russell M. Kobert
Attorney's Docket No. MI22-2379
Customer No.021567
Title: Method and Apparatus for Testing Semiconductor Circuitry for Operability and
Method of Forming Apparatus for Testing Semiconductor Circuitry for Operability

EXAMINER INTERVIEW SUMMARY OF SEPTEMBER 7, 2005

To: Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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Applicant's representative held an interview with Examiner Kobert on September 7, 2005. Applicant's representative would like to thank Examiner Kobert for his time and attention to this matter.

Applicant's representative directed Examiner's attention to the "selected portion of Figure 4" presented by the Examiner in the pending office action (pg. 3, paper no. 0605). Applicant's representative directed the Examiner's attention to an important inconsistency of the figure. That is, the figure illustrates an alleged "substrate (portion of 40)" and an

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alleged "lateral dimension of substrate" illustrated as a horizontal arrow which clearly does not correspond to a lateral dimension of the substrate. The Examiner stated he understood Applicant's position and encouraged the Applicant to describe the inconsistency in a subsequently-filed response. Applicant's representative stated he would do so.

Applicant's representative is greatly appreciative of Examiner Kobert's consideration of this matter.

Respectfully submitted,

Dated: 9-13-05By: 

D. Brent Kenady
Reg. No. 40,045